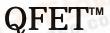


December 2000



FQP10N20L

200V LOGIC N-Channel MOSFET

General Description

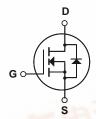
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation modes. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supplies, and motor control.

Features

- 10A, 200V, $R_{DS(on)} = 0.36\Omega @V_{GS} = 10 V$
- Low gate charge (typical 13 nC)
- Low Crss (typical 14 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- Low level gate drive requirement allowing direct operation from logic drivers





Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	95\//p =	FQP10N20L	Units
V _{DSS}	Drain-Source Voltage	100	200	V
I _D	Drain Current - Continuous (T _C = 25°C)		10	А
	- Continuous (T _C = 100°C))	6.3	А
I _{DM}	Drain Current - Pulsed	(Note 1)	40	А
V _{GSS}	Gate-Source Voltage		± 20	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	180	mJ
I _{AR}	Avalanche Current	(Note 1)	10	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	8.7	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P_{D}	Power Dissipation (T _C = 25°C)	470.7	87	W
	- Derate above 25°C	EAV/2	0.7	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.44	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

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Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced t	to 25°C		0.18		V/°C
I _{DSS}	Zara Oata Walta ya Basia Oama d	V _{DS} = 200 V, V _{GS} = 0 V				1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 160 V, T _C = 125°C				10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
On Cha	racteristics		·	·			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1.0		2.0	V
R _{DS(on)}	Static Drain-Source	V _{GS} = 10 V, I _D = 5.0 A			0.29	0.36	
DO(011)	On-Resistance	$V_{GS} = 5 \text{ V}, I_D = 5.0 \text{ A}$	(Note 4)		0.3	0.38	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 5.0 \text{ A}$			10.7		S
	ic Characteristics				640	830	nE.
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			95	125	pF pF
C _{oss}	Output Capacitance Reverse Transfer Capacitance				14	125	рF
Orss	Reverse Transfer Capacitance				14	10	рг
Switchi	ng Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 100 V, I _D = 10 A,			13	35	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$			150	310	ns
t _{d(off)}	Turn-Off Delay Time	(Note 4, 5)			50	110	ns
t _f	Turn-Off Fall Time				95	200	ns
Qg	Total Gate Charge	V _{DS} = 160 V, I _D = 10 A,			13	17	nC
Q _{gs}	Gate-Source Charge	-	Note 4, 5)		2.4		nC
Q _{gd}	Gate-Drain Charge				6.1		nC
Drain-S	ource Diode Characteristics a	nd Maximum Ratings	·				
I _S	Maximum Continuous Drain-Source Diode Forward Current					10	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	ed Drain-Source Diode Forward Current				40	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 10 A				1.5	V
	Reverse Recovery Time	V _{GS} = 0 V, I _S = 10 A,	(Note 4)		120		ns
t _{rr}	Reverse Recovery Time	VGS - 0 V, IS - 10 / L,	` '	J.	0		

Notes:1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.7mH, I_{AS} = 10A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} \leq 10A, di/dt \leq 300A/µs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

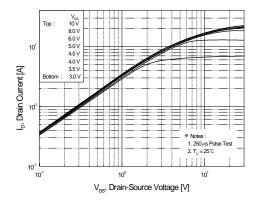


Figure 1. On-Region Characteristics

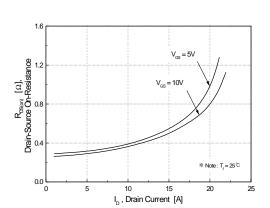


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

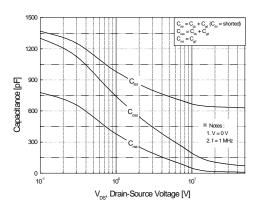


Figure 5. Capacitance Characteristics

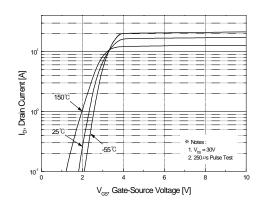


Figure 2. Transfer Characteristics

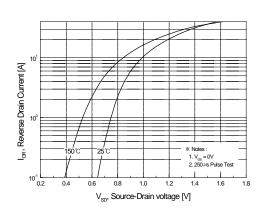


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

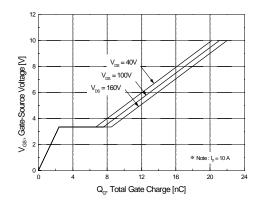
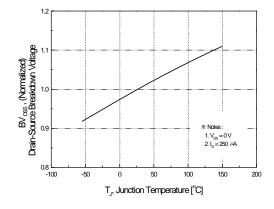


Figure 6. Gate Charge Characteristics

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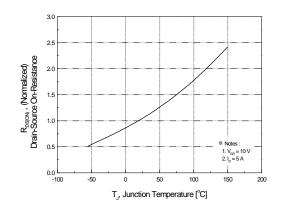
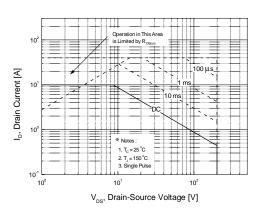


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



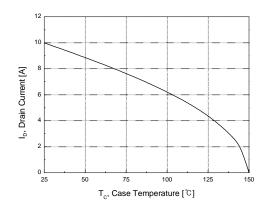


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

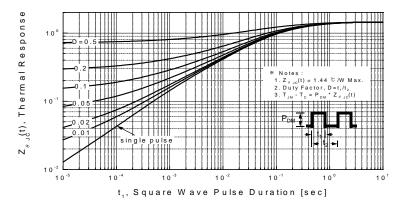
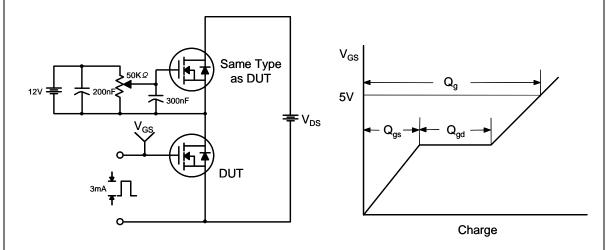


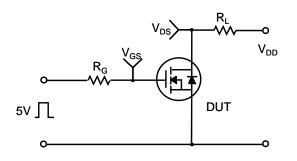
Figure 11. Transient Thermal Response Curve

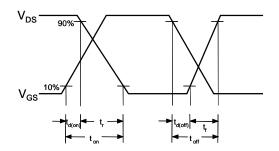
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Gate Charge Test Circuit & Waveform

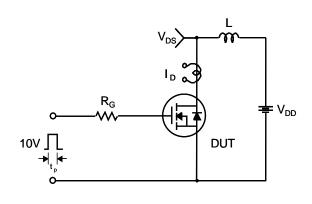


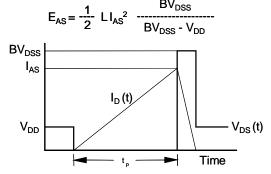
Resistive Switching Test Circuit & Waveforms



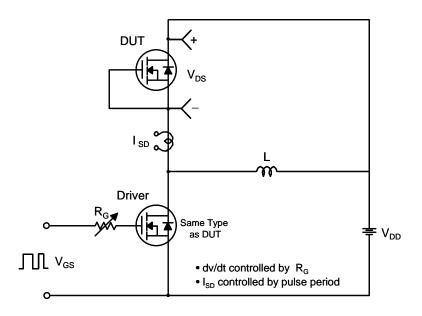


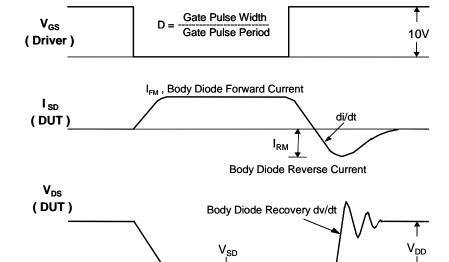
Unclamped Inductive Switching Test Circuit & Waveforms





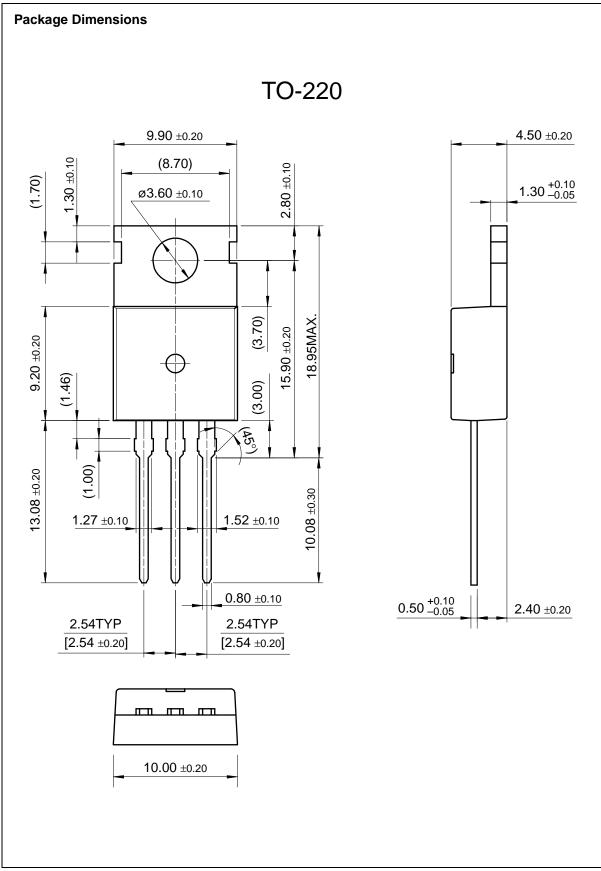
Peak Diode Recovery dv/dt Test Circuit & Waveforms





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Body Diode Forward Voltage Drop



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